Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/766,971	BONG, YIN YEN	
Examiner	Art Unit	
Chris C. Chu	2815	

	SEAR	CHED	
Class	Subclass	Date	Examiner
257	E23.19, E23.177 & E23.07	6/29/2006	C.C.
257	E23.065	6/29/2006	C.C.
257	678	6/29/2006	c.c.

INT	ERFERENC	CE SEARCH	SEARCHED		
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Searched in US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; and IBM_TDB;	6/29/2006	C.C.		
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